



Buy







CSD19533KCS

SLPS482B-DECEMBER 2013-REVISED JANUARY 2015

CSD19533KCS, 100 V N-Channel NexFET™ Power MOSFET

Features 1

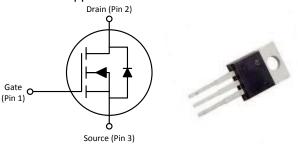
- Ultra-Low Q_a and Q_{ad}
- Low Thermal Resistance
- Avalanche Rated
- Pb Free Terminal Plating
- **RoHS** Compliant
- Halogen Free
- **TO-220 Plastic Package**

Applications 2

- Secondary Side Synchronous Rectifier
- Motor Control

Description 3

This 100 V, 8.7 mΩ, TO-220 NexFET™ power MOSFET is designed to minimize losses in power conversion applications.



Product Summary

T _A = 25°	C	TYPICAL VA	UNIT	
V _{DS}	Drain-to-Source Voltage	V		
Qg	Gate Charge Total (10 V)	27	nC	
Q _{gd}	Gate Charge Gate-to-Drain	5.4		nC
D	Drain-to-Source On-Resistance	V _{GS} = 6 V 9.7		mΩ
R _{DS(on)}	Drain-to-Source On-Resistance	V _{GS} = 10 V 8.7		mΩ
V _{GS(th)}	Threshold Voltage	2.8		V

Ordering Information⁽¹⁾

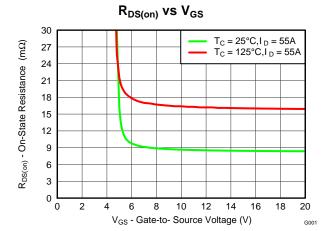
Device	Package	Media	Qty	Ship
CSD19533KCS	TO-220 Plastic Package	Tube	50	Tube

(1) For all available packages, see the orderable addendum at the end of the data sheet.

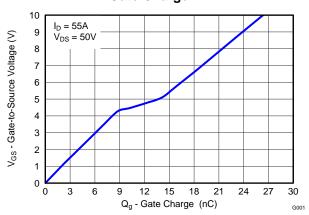
Absolute Maximum Ratings

T _A = 2	5°C	VALUE	UNIT
V _{DS}	Drain-to-Source Voltage	100	V
V_{GS}	Gate-to-Source Voltage	±20	V
	Continuous Drain Current (Package limited)	100	
I _D	Continuous Drain Current (Silicon limited), $T_C = 25^{\circ}C$	86	A
	Continuous Drain Current (Silicon limited), $T_{C} = 100^{\circ}C$	61	
I _{DM}	Pulsed Drain Current ⁽¹⁾	207	А
PD	Power Dissipation	188	W
T _J , T _{stg}	Operating Junction and Storage Temperature Range	-55 to 175	°C
E _{AS}	Avalanche Energy, single pulse I_D = 46 A, L = 0.1 mH, R_G = 25 Ω	106	mJ

(1) Max $R_{\theta JC} = 0.8^{\circ}C/W$, pulse duration $\leq 100 \ \mu s$, Duty cycle $\leq 1\%$



Gate Charge





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4 Revision History

C	Changes from Revision A (July 2014) to Revision B									
•	Changed Q _{rr} to 211 nC									
C	hanges from Original (December 2013) to Revision A	Page								
•	Pulsed drain current increased from 104 to 207 A	1								
•	Updated pulsed current conditions									
•	Updated Figure 10 to reflect increased pulsed drain current									

5 Specifications

5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC	CHARACTERISTICS		U	1	
BV _{DSS}	Drain-to-Source Voltage	V _{GS} = 0 V, I _D = 250 μA	100		V
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0 V, V _{DS} = 80 V		1	μA
I _{GSS}	Gate-to-Source Leakage Current	$V_{DS} = 0 V, V_{GS} = 20 V$		100	nA
V _{GS(th)}	Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2.2 2.8	3.4	V
D	Drain to Source On Registeres	V _{GS} = 6 V, I _D = 55 A	9.7	12.2	mΩ
R _{DS(on)}	Drain-to-Source On-Resistance	V _{GS} = 10 V, I _D = 55 A	8.7	10.5	mΩ
9 _{fs}	Transconductance	V _{DS} = 10 V, I _D = 55 A	115		S
DYNAMI	C CHARACTERISTICS		L		
C _{iss}	Input Capacitance		2050	2670	pF
C _{oss}	Output Capacitance	$V_{GS} = 0 V, V_{DS} = 50 V, f = 1 MHz$	395	514	pF
C _{rss}	Reverse Transfer Capacitance		9.6	12.5	pF
R _G	Series Gate Resistance		1.2	2.4	Ω
Qg	Gate Charge Total (10 V)		27	35	nC
Q _{gd}	Gate Charge Gate-to-Drain		5.4		nC
Q _{gs}	Gate Charge Gate-to-Source	V _{DS} = 50 V, I _D = 55 A	9		nC
Q _{g(th)}	Gate Charge at V _{th}		3.9		nC
Q _{oss}	Output Charge	V _{DS} = 50 V, V _{GS} = 0 V	79		nC
t _{d(on)}	Turn On Delay Time		7		ns
t _r	Rise Time	V _{DS} = 50 V, V _{GS} = 10 V,	5		ns
t _{d(off)}	Turn Off Delay Time	$I_{DS} = 55 \text{ A}, \text{ R}_{G} = 0 \Omega$	12		ns
t _f	Fall Time		2		ns
DIODE C	HARACTERISTICS	•			
V_{SD}	Diode Forward Voltage	I _{SD} = 55 A, V _{GS} = 0 V	0.9	1.1	V
Q _{rr}	Reverse Recovery Charge	V _{DS} = 50 V, I _F = 55 A,	211		nC
t _{rr}	Reverse Recovery Time	$di/dt = 300 \text{ A}/\mu\text{s}$	77		ns

5.2 Thermal Information

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	THERMAL METRIC	MIN	TYP	MAX	UNIT			
$R_{ extsf{ heta}JC}$	Junction-to-Case Thermal Resistance			0.8	°C M			
$R_{\theta J A}$	Junction-to-Ambient Thermal Resistance			62	°C/W			

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NSTRUMENTS

Texas

5.3 Typical MOSFET Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

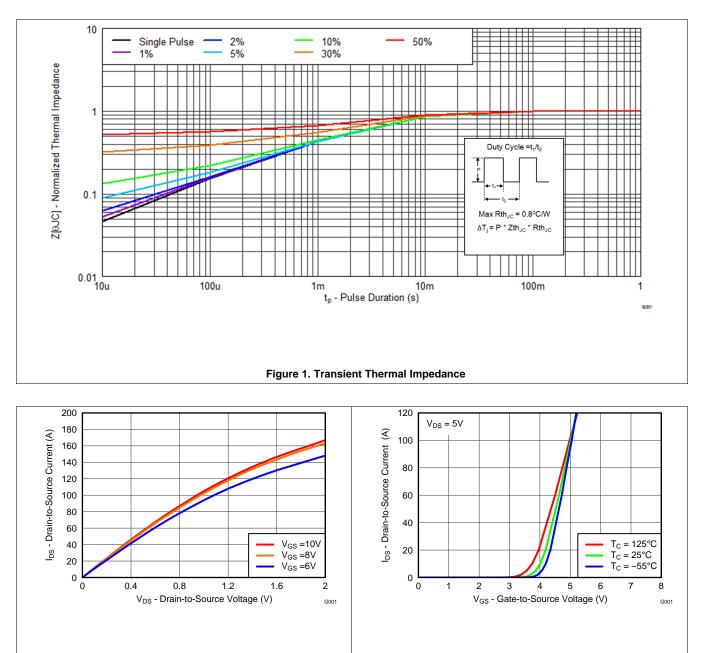
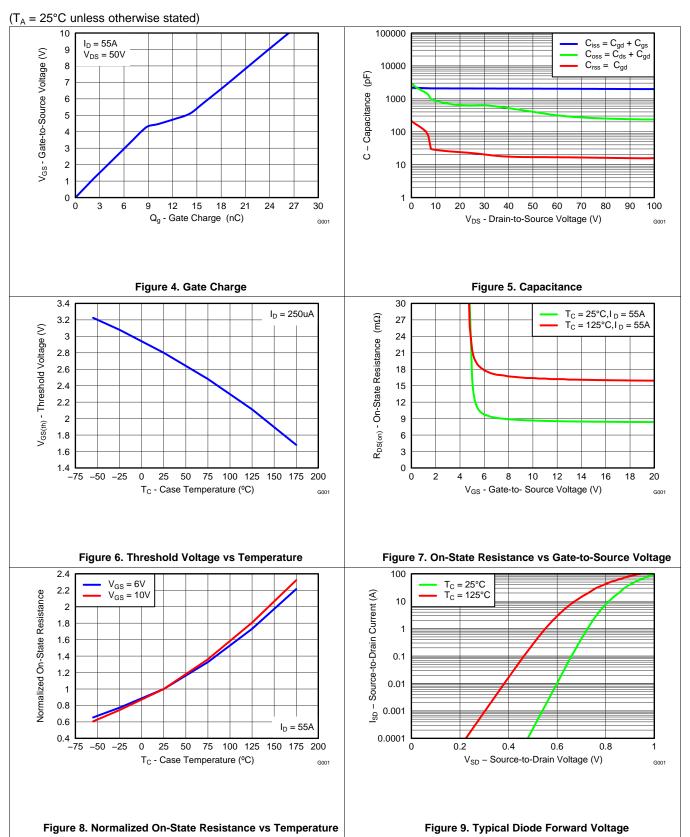


Figure 2. Saturation Characteristics

Figure 3. Transfer Characteristics

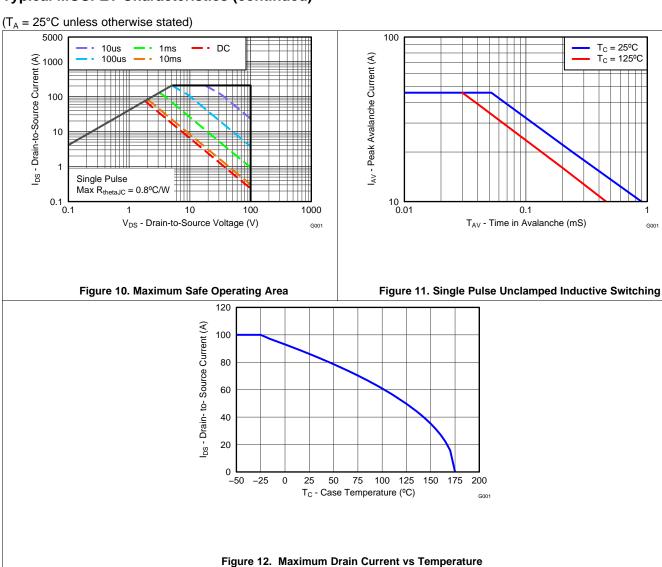


Typical MOSFET Characteristics (continued)





Typical MOSFET Characteristics (continued)





6 Device and Documentation Support

6.1 Trademarks

NexFET is a trademark of Texas Instruments.

6.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

6.3 Glossary

SLYZ022 — TI Glossary.

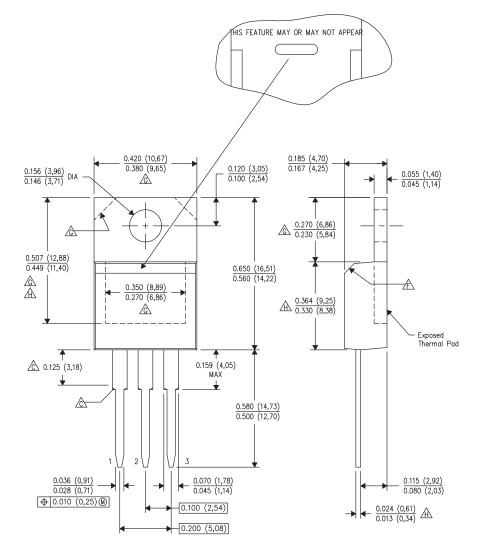
This glossary lists and explains terms, acronyms, and definitions.



7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

7.1 KCS Package Dimensions



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

- Lead dimensions are not controlled within this area. Chamfer may or may not appear
- D. All lead dimensions apply before solder dip.
 E. The center lead is in electrical contact with the mounting tab.
- \triangle The chamfer is optional.
- Thermal pad contour optional within these dimensions.
- A Falls within JEDEC T0-220 variation AB, except minimum lead thickness, minimum exposed pad length, and maximum body length.

D '	~	<i>c</i> -	
Pin	(Co)	ntiai	uration

Position	Designation
Pin 1	Gate
Pin 2 / Tab	Drain
Pin 3	Source



9-Jun-2020

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CSD19533KCS	ACTIVE	TO-220	KCS	3	50	Green (RoHS & no Sb/Br)	SN	N / A for Pkg Type	-55 to 175	CSD19533KCS	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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